

## Automotive MOSFET OptiMOS™ 5 Power-Transistor

### Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel - Enhancement mode - Logic Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested

### Potential applications

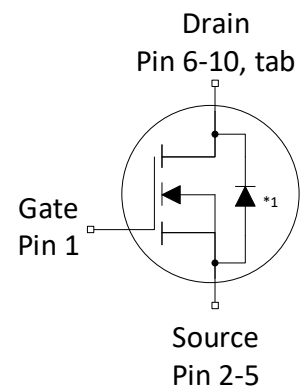
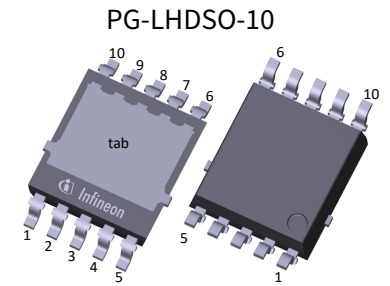
General automotive applications.

### Product validation

Qualified according to Automotive applications.  
Product validation according to AEC-Q101.

**Table 1** Key performance parameters

Parameter	Value	Unit
$V_{DS}$	80	V
$R_{DS(on)}$	15.8	mΩ
$I_D$ (chip limited)	42	A



\*1: Internal body diode



Part number	Package	Marking	Related links
IAUCN08S5L160T	PG-LHDSO-10	5B8	see Appendix A



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## 1 Maximum ratings

at  $T_j=25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current	$I_D$	-	-	42	A	Chip limitation, $V_{GS} = 10\text{ V}$ <sup>1) 2)</sup>
				42		DC current, $V_{GS} = 10\text{ V}$
				17		$R_{thJA}$ on 2s2p, $V_{GS} = 10\text{ V}$ , $T_a = 100\text{ °C}$ <sup>1) 3)</sup>
Pulsed drain current <sup>1)</sup>	$I_{D,pulse}$	-	-	84	A	$T_C = 25\text{ °C}$ , $t_p = 100\text{ }\mu\text{s}$
Avalanche energy, single pulse <sup>1)</sup>	$E_{AS}$	-	-	55	mJ	$I_D = 9\text{ A}$
Avalanche current, single pulse	$I_{AS}$	-	-	18	A	-
Gate source voltage	$V_{GS}$	-20	-	20	V	-
Power dissipation	$P_{tot}$	-	-	60	W	$T_C = 25\text{ °C}$
Operating temperature	$T_j$	-55	-	175	°C	-

<sup>1)</sup> The parameter is not subject to production testing - specified by design.

<sup>2)</sup> The current is limited by the overall system design, including the customer-specific PCB.

<sup>3)</sup> Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case 4)	$R_{thJC}$	-	-	2.46	K/W	-
Thermal characterization parameter, source pin 4) 5)	$\psi_{source}$	-	13.9	-		
Thermal characterization parameter, drain pin 4) 6)	$\psi_{drain}$	-	10.5	-		
Thermal resistance, junction - heatsink 4) 7)	$R_{thJH}$	-	9.1	-		
Thermal resistance, junction - ambient 4) 8)	$R_{thJA}$	-	47.9	-		

4) The parameter is not subject to production testing - specified by design.

5) Thermal characterization parameter, calculated as  $\psi_{source} = (T_{source} - T_{ambient})/P_{dis}$  in condition of 3). Used to determine PCB temperature at source pins for given power.

6) Thermal characterization parameter, calculated as  $\psi_{drain} = (T_{drain} - T_{ambient})/P_{dis}$  in condition of 3). Used to determine PCB temperature at drain pins for given power.

7) Device on 2s2p FR4 PCB defined in acc. with JEDEC standards (JESD51-5,-7) without thermal vias, heat sink of 71 x 110 x 2 mm is attached through TIM with 3.3 W/(m\*K) and 400  $\mu$ m thickness to top side pad. Heatsink fixed to 85°C ambient temperature.

8) Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

## 3 Electrical characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	80	-	-	V	$I_D = 1\text{ mA}, V_{GS} = 0\text{ V}$
Gate threshold voltage	$V_{GS(th)}$	1.2	1.6	2	V	$V_{DS}=V_{GS}, I_D = 15\ \mu\text{A}$
Zero gate voltage drain current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$V_{DS} = 80\text{ V}, T_j = 25^\circ\text{C}, V_{GS} = 0\text{ V}$
				20		$V_{DS} = 80\text{ V}, T_j = 100^\circ\text{C}, V_{GS} = 0\text{ V}^9)$
Gate-source leakage current	$I_{GSS}$	-	-	100	nA	$V_{DS} = 0\text{ V}, V_{GS} = 20\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	17.9	23.5	m $\Omega$	$I_D = 21\text{ A}, V_{GS} = 4.5\text{ V}$
			14.3	15.8		$I_D = 21\text{ A}, V_{GS} = 10\text{ V}$
Gate resistance <sup>9)</sup>	$R_G$	-	1.1	-	$\Omega$	-

9) The parameter is not subject to production testing - specified by design.

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance <sup>10)</sup>	$C_{iss}$	-	810	1050	pF	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$
Output capacitance <sup>10)</sup>	$C_{oss}$	-	140	190		
Reverse transfer capacitance <sup>10)</sup>	$C_{rss}$	-	11	17		
Turn-on delay time <sup>10)</sup>	$t_{d(on)}$	-	3	-	ns	$I_D = 21\text{ A}, V_{GS} = 10\text{ V}, V_{DD} = 40\text{ V}, R_G = 3.5\ \Omega$
Rise time <sup>10)</sup>	$t_r$		3			
Turn-off delay time <sup>10)</sup>	$t_{d(off)}$		10			
Fall time <sup>10)</sup>	$t_f$		7			

<sup>10)</sup> The parameter is not subject to production testing - specified by design.

**Table 6 Gate Charge Characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge <sup>11)</sup>	$Q_{gs}$	-	2.6	3.4	nC	$I_D = 21\text{ A}, V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V to } 10\text{ V}$
Gate to drain charge <sup>11)</sup>	$Q_{gd}$		4	5	nC	
Gate charge total <sup>11)</sup>	$Q_g$		15	19	nC	
Gate plateau voltage <sup>11)</sup>	$V_{plateau}$		3.2	-	V	

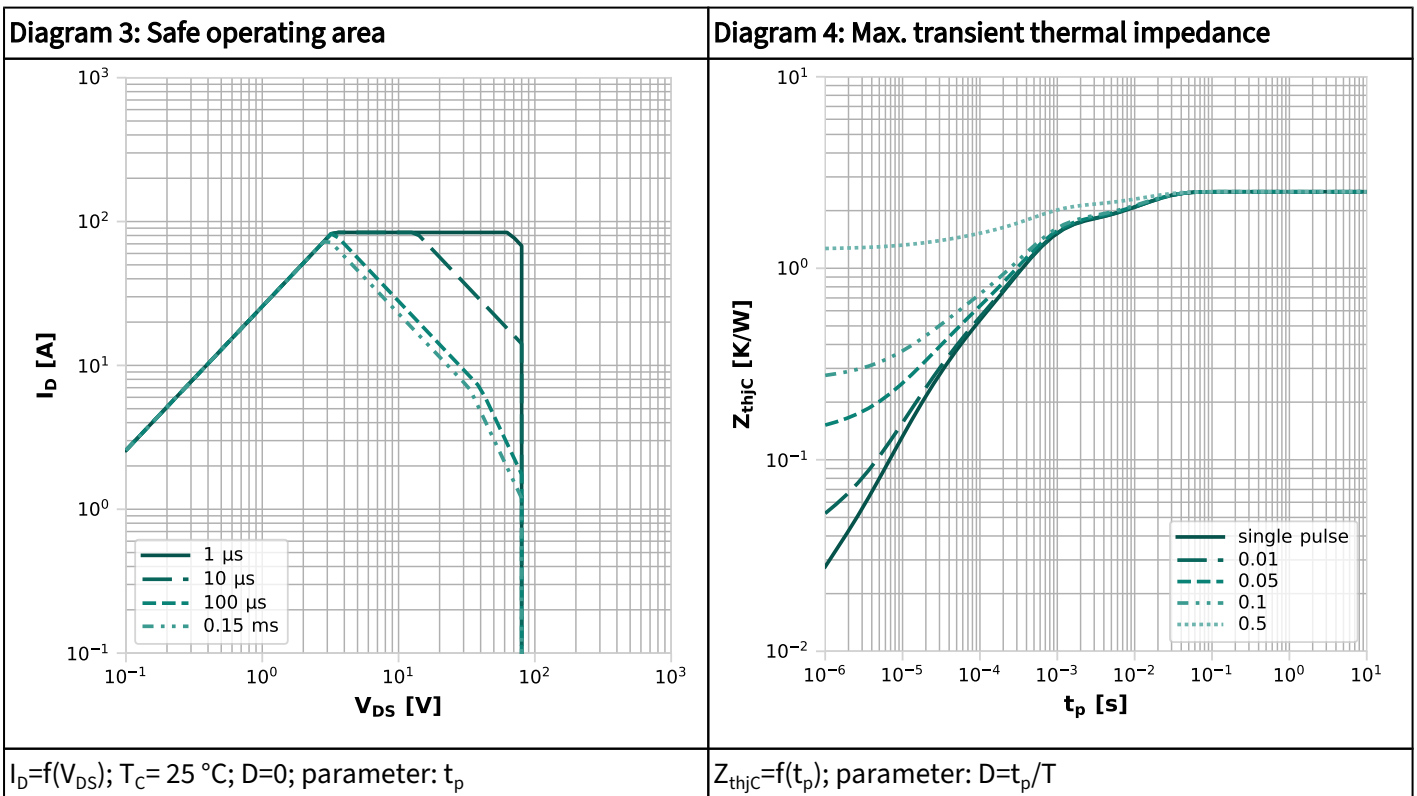
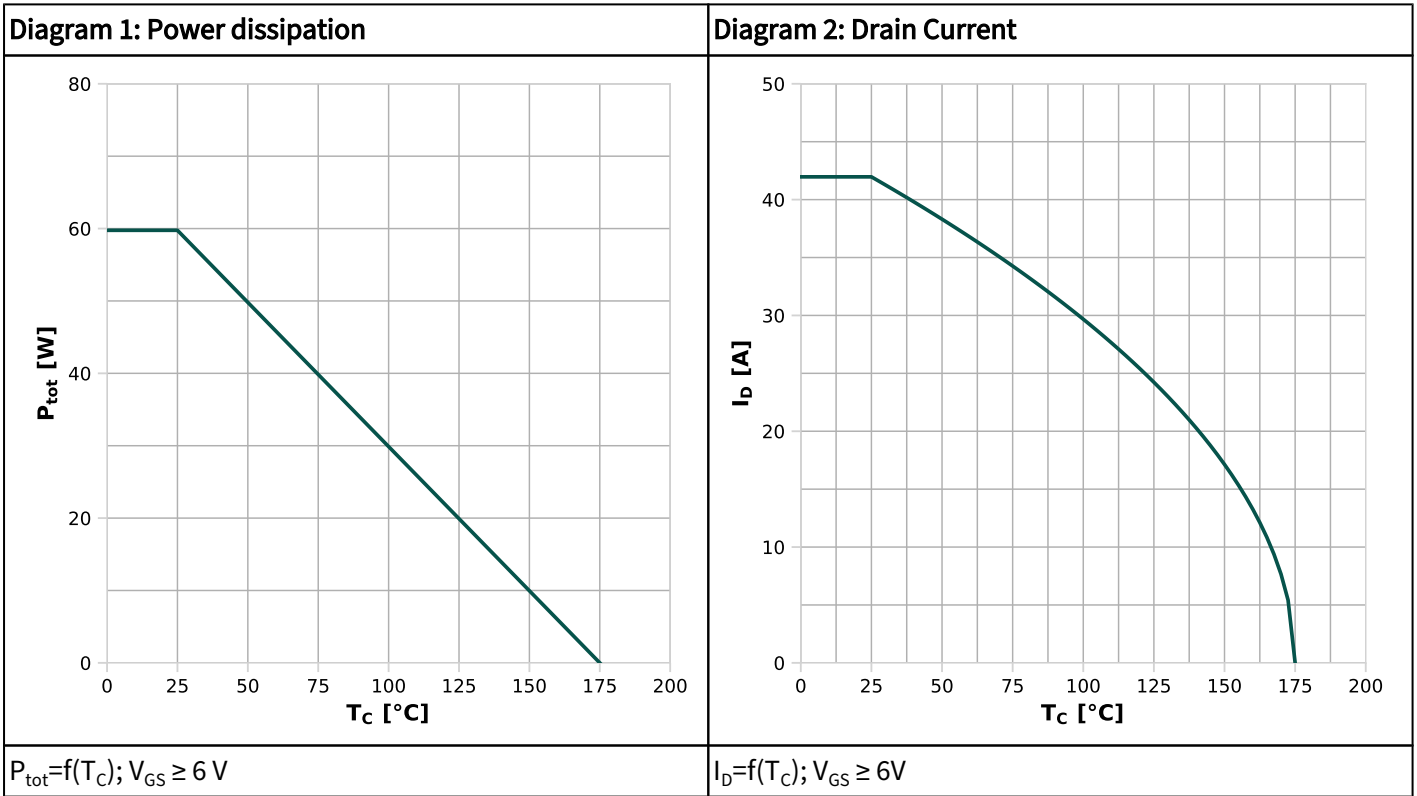
<sup>11)</sup> The parameter is not subject to production testing - specified by design.

**Table 7 Reverse Diode**

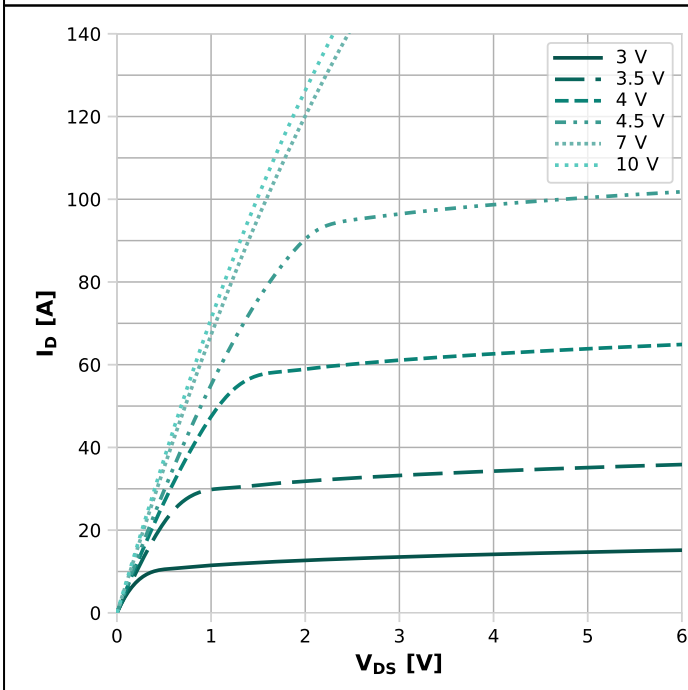
Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode continuous forward current <sup>12)</sup>	$I_S$	-	-	42	A	$T_C = 25\text{ }^\circ\text{C}$
Diode pulse current <sup>12)</sup>	$I_{S,pulse}$	-	-	84	A	$T_C = 25\text{ }^\circ\text{C}, t_p = 100\ \mu\text{s}$
Diode forward voltage	$V_{SD}$	-	0.9	1.2	V	$T_j = 25\text{ }^\circ\text{C}, V_{GS} = 0\text{ V}, I_F = 21\text{ A}$
Reverse recovery time <sup>12)</sup>	$t_{rr}$	-	21	32	ns	$di_F/dt = 100\text{ A}/\mu\text{s}, V_R = 40\text{ V}, I_F = 42\text{ A}$
Reverse recovery charge <sup>12)</sup>	$Q_{rr}$		10	20	nC	

<sup>12)</sup> The parameter is not subject to production testing - specified by design.

## 4 Electrical characteristics diagrams

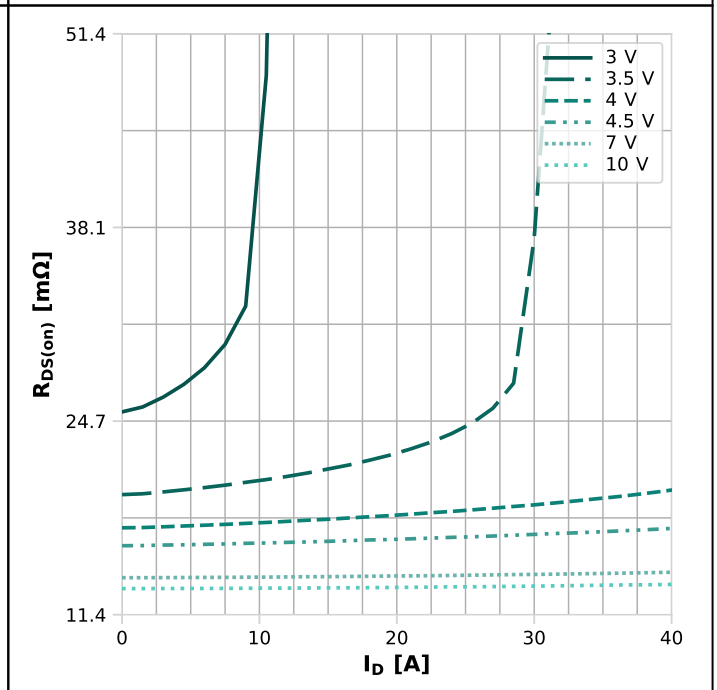


**Diagram 5: Typ. output characteristics**



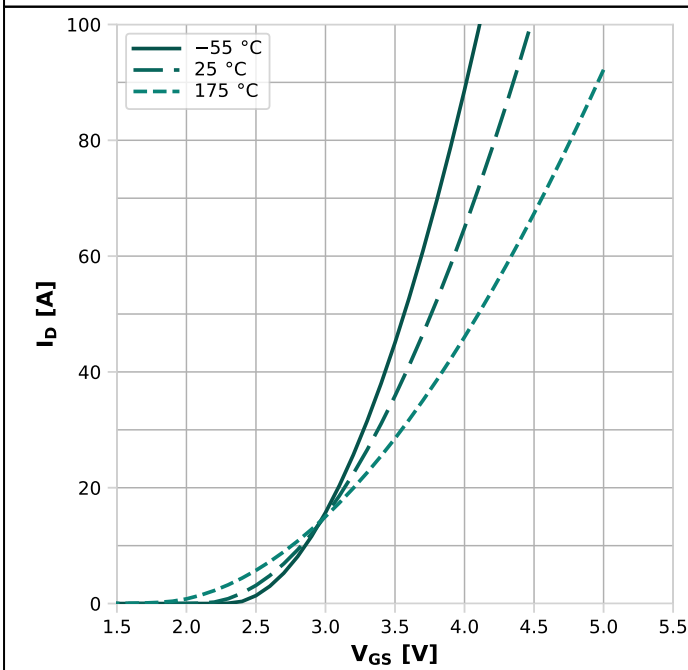
$I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

**Diagram 6: Typ. drain-source on-state resistance**



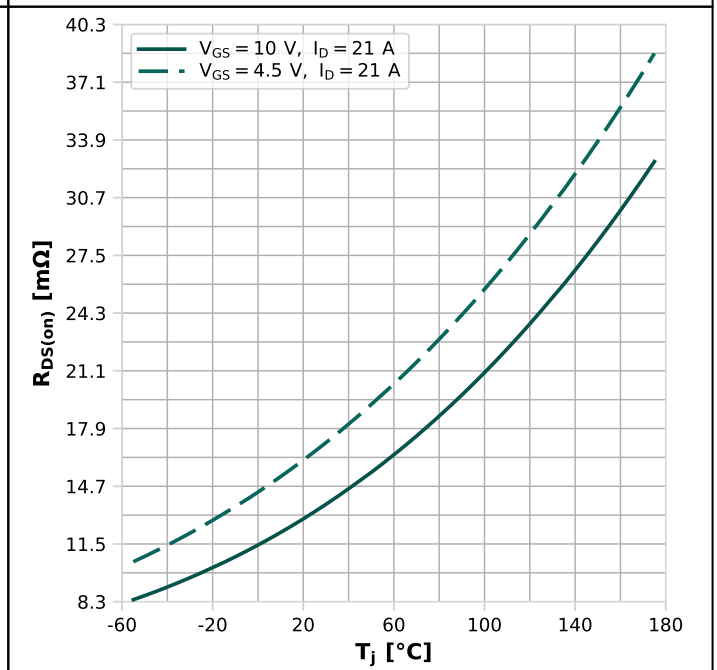
$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

**Diagram 7: Typ. transfer characteristics**



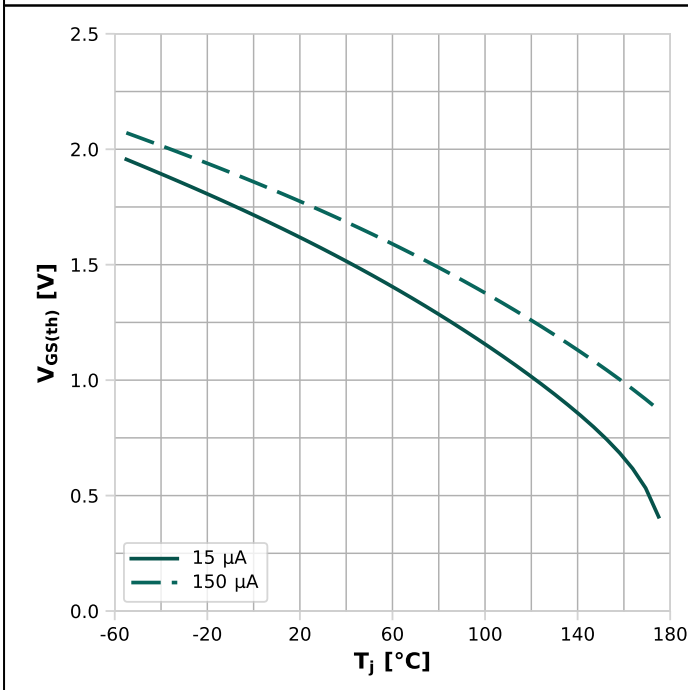
$I_D = f(V_{GS}); V_{DS} = 6\text{ V}; \text{parameter: } T_j$

**Diagram 8: Typ. drain-source on-state resistance**



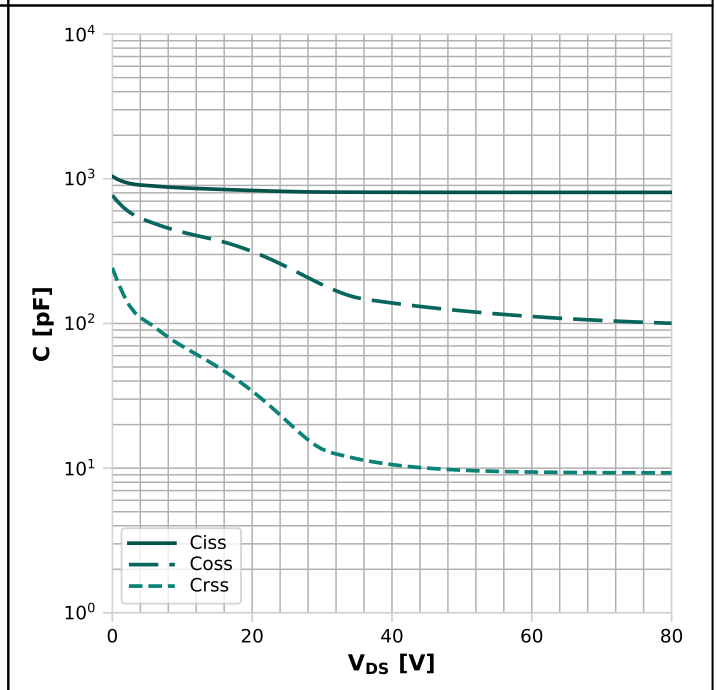
$R_{DS(on)} = f(T_j); \text{parameter: } I_D, V_{GS}$

**Diagram 9: Typ. gate threshold voltage**



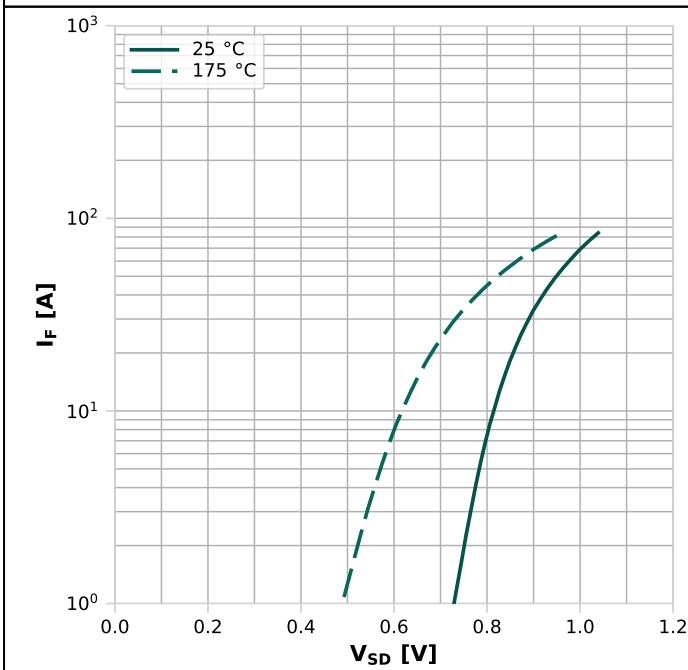
$V_{GS(th)}=f(T_j); V_{GS}=V_{DS}; \text{parameter: } I_D$

**Diagram 10: Typ. capacitances**



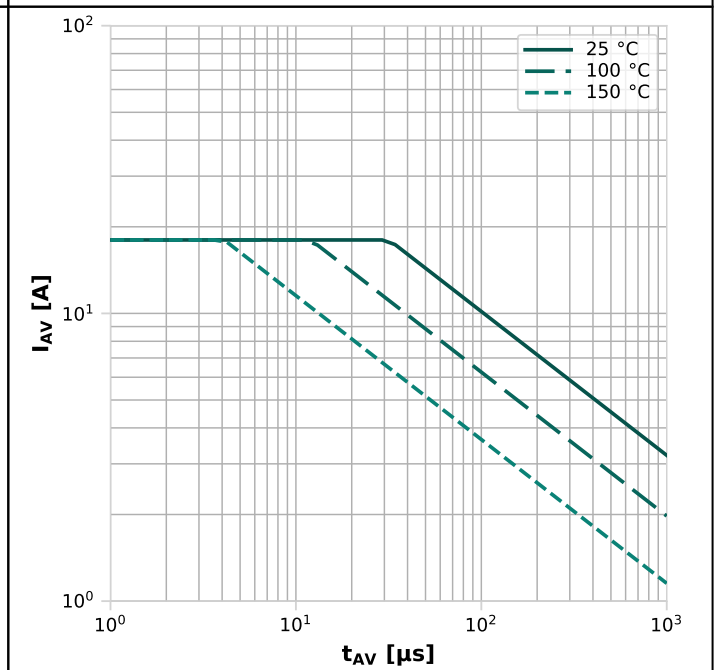
$C=f(V_{DS}); V_{GS}=0 \text{ V}; f=1 \text{ MHz}$

**Diagram 11: Typ. forward diode characteristics**



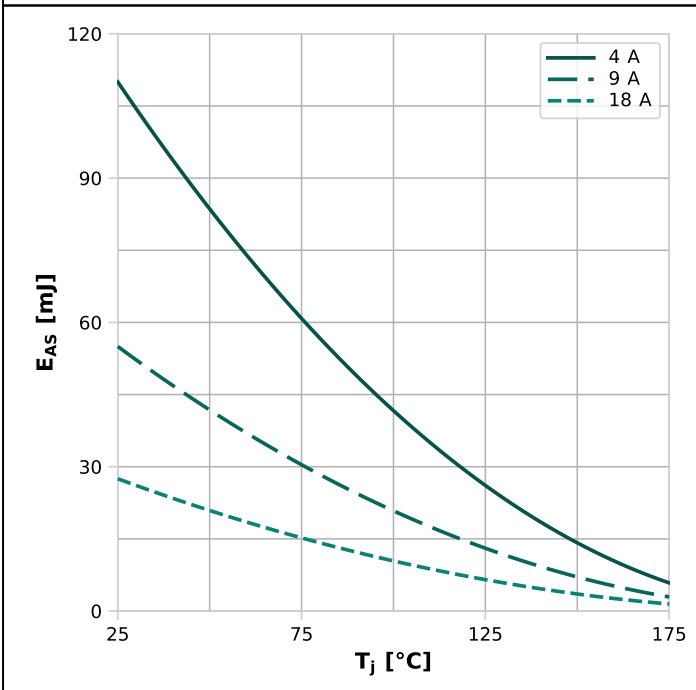
$I_F=f(V_{SD}); \text{parameter: } T_j$

**Diagram 12: Typ. avalanche characteristics**



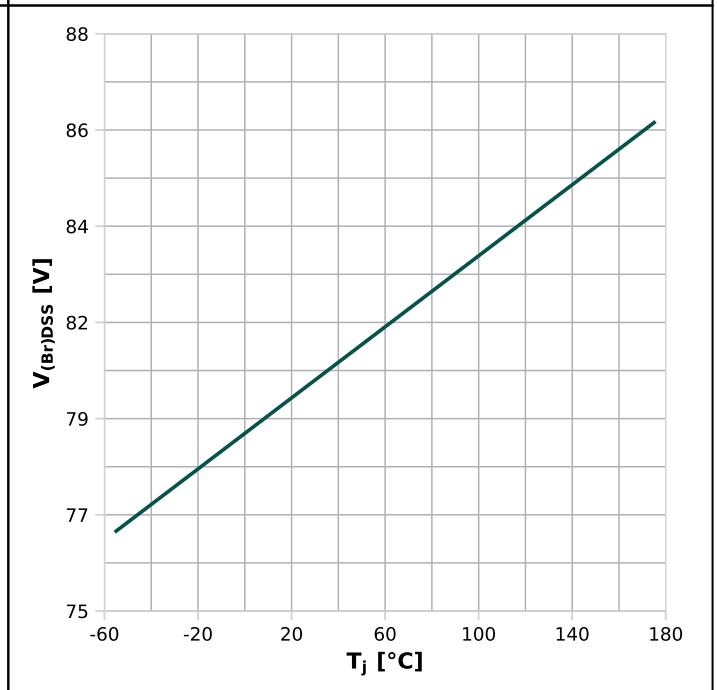
$I_{AS}=f(t_{AV}); \text{parameter: } T_{j(start)}$

**Diagram 13: Typical avalanche Energy**



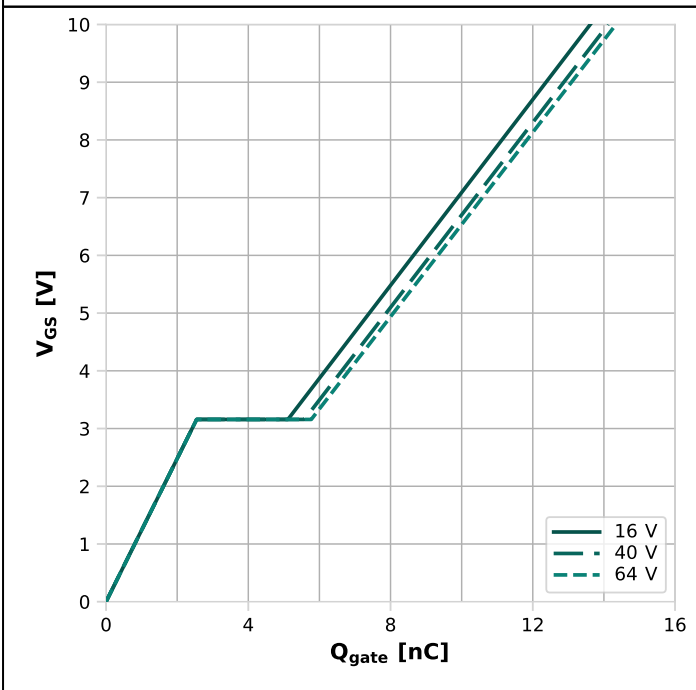
$E_{AS}=f(T_j)$ ; parameter:  $I_D$

**Diagram 14: Drain-source breakdown voltage**



$V_{(Br)DSS}=f(T_j)$ ;  $I_D=1\text{ mA}$

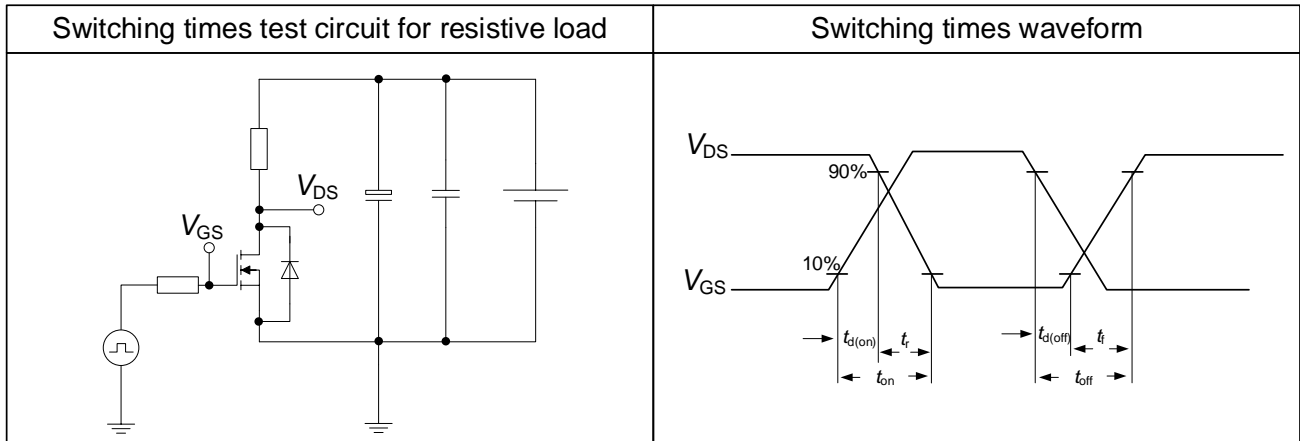
**Diagram 15: Typ. gate charge**



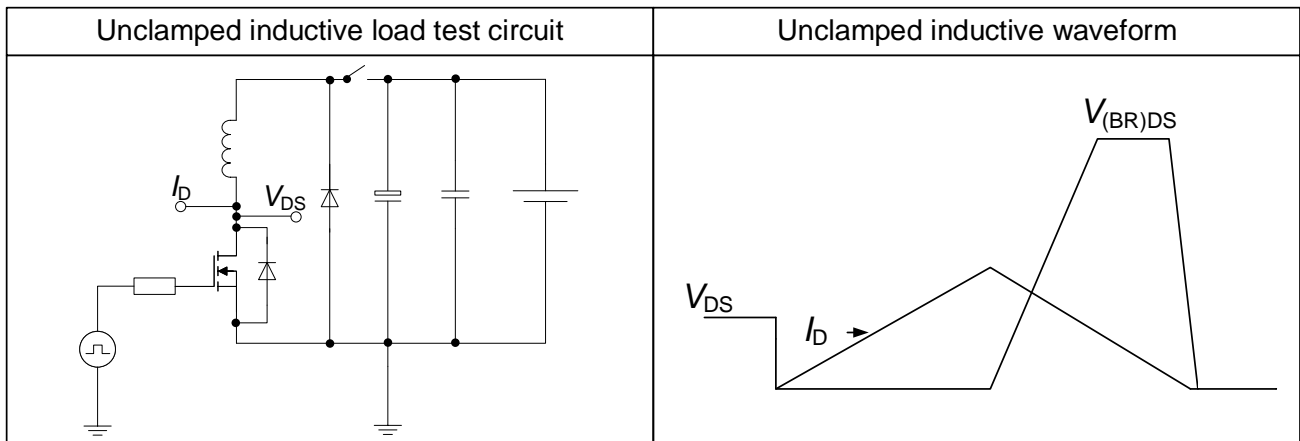
$V_{GS}=f(Q_{gate})$ ;  $I_D=21\text{ A pulsed}$ ; parameter:  $V_{DD}$

## 5 Test circuits

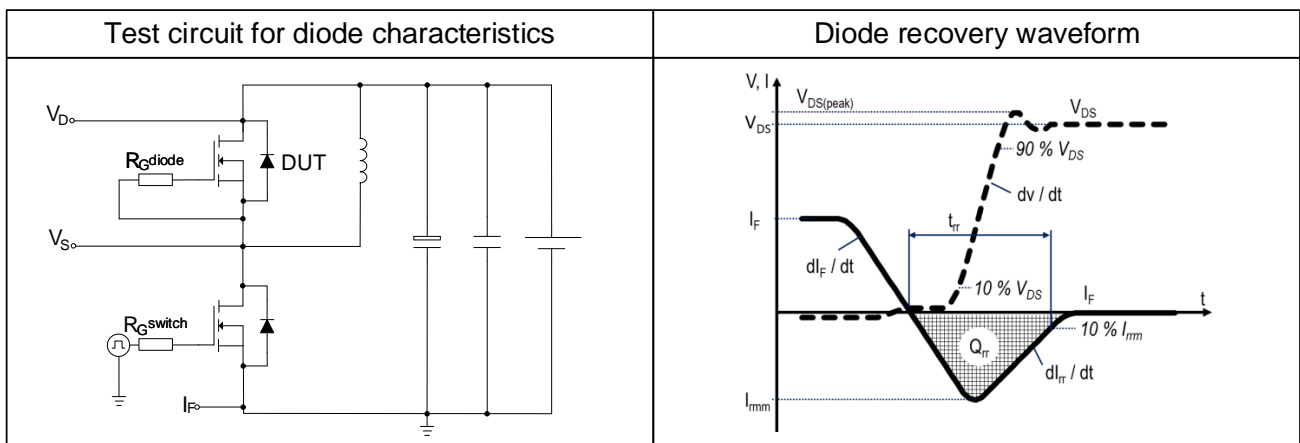
**Table 8 Switching times test circuit for resistive load**



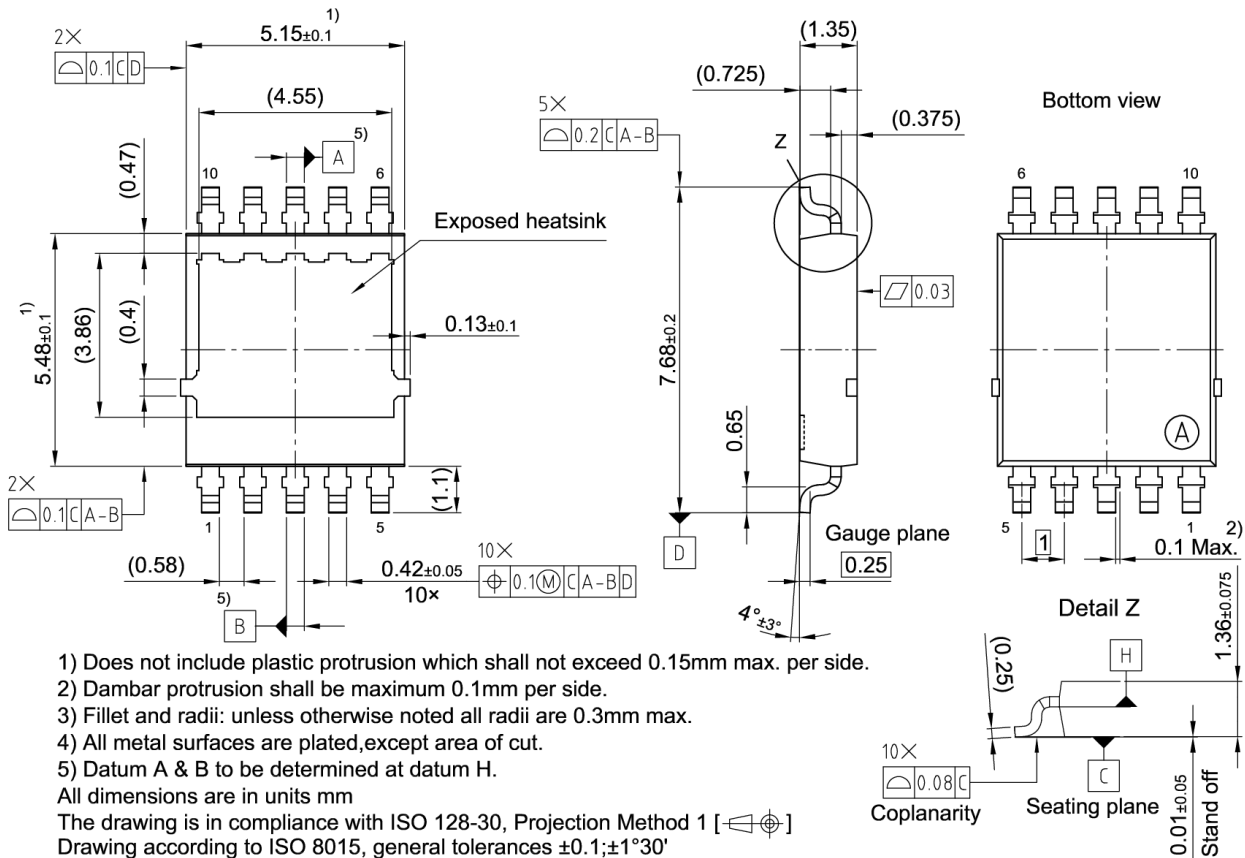
**Table 9 Unclamped inductive load test circuit**



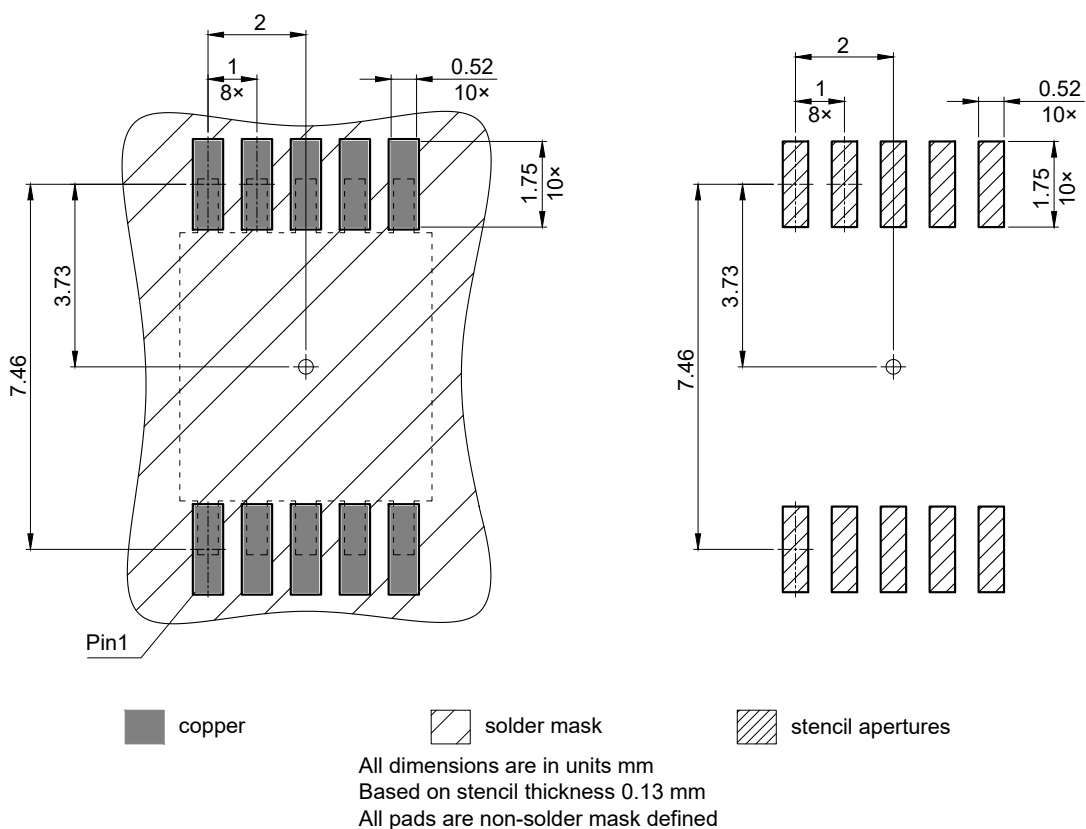
**Table 10 Diode characteristics**



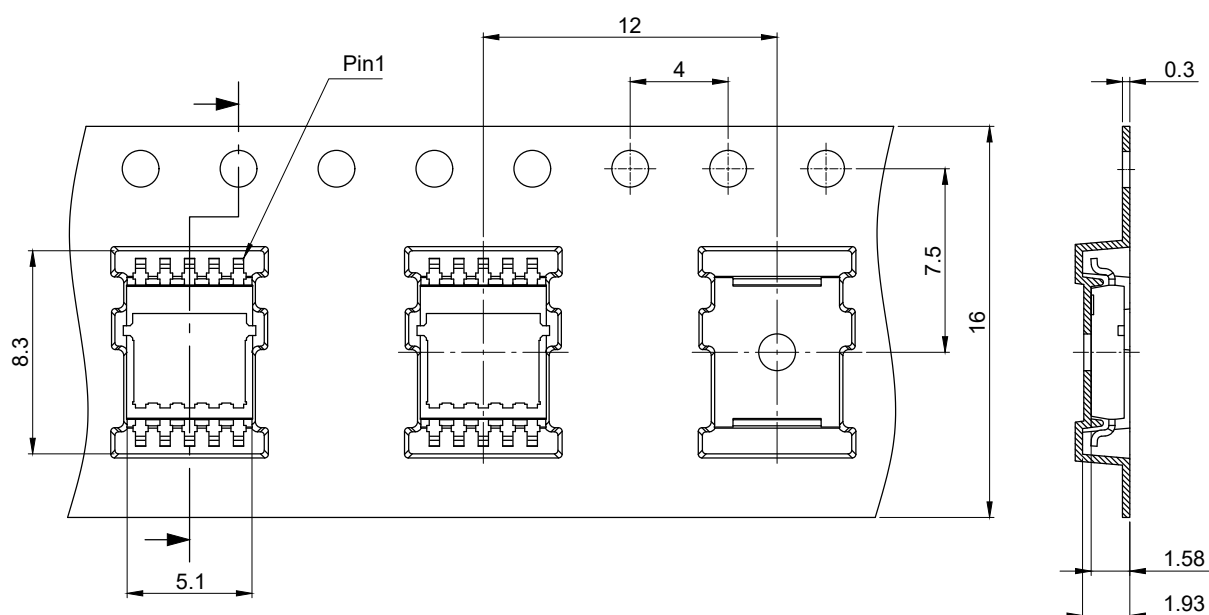
## 6 Package outlines




**Figure 1 Outline PG-LHDSO-10, dimensions in mm**



**Figure 2 Footprint drawing PG-LHDSO-10, dimensions in mm**



All dimensions are in units mm  
 The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]

**Figure 3** Packaging variant PG-LHDSO-10, dimensions in mm

## 7 Appendix A

### Table 11 Related links

- [IFX Optimos™ Power-Transistor Webpage](#)

## Revision history

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IAUCN08S5L160T

### Revision 2026-03-04, Rev. 1.1

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Previous revisions

Revision	Date	Subjects (major changes since last revision)
1.0	2026-02-24	Final Data Sheet
1.1	2026-03-04	Corrected confidentiality level

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